Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/667,513	WU ET AL.	
Examiner	Art Unit	
Hoai-An D. Nguyen	2858	

	SEAR	CHED	
Class	Subclass	Date	Examiner
324	601	12/22/2004	HADN
324	600	12/22/2004	HADN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEAR)
	DATE	EXMR
Text search in East.	12/22/2004	HADN
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